

# F91 Series



## Low ESR, Resin-Molded Chip J-Lead



### FEATURES

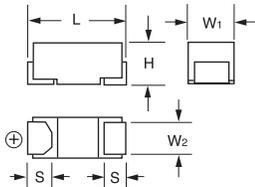
- Compliant to the RoHS2 directive 2011/65/EU
- SMD J-lead
- Low ESR



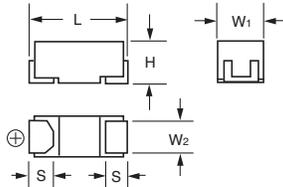
### APPLICATIONS

- General medium power DC/DC convertors

#### B CASE



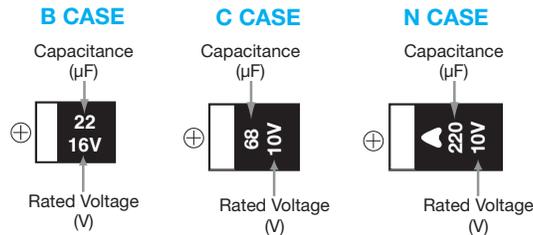
#### C, N CASE



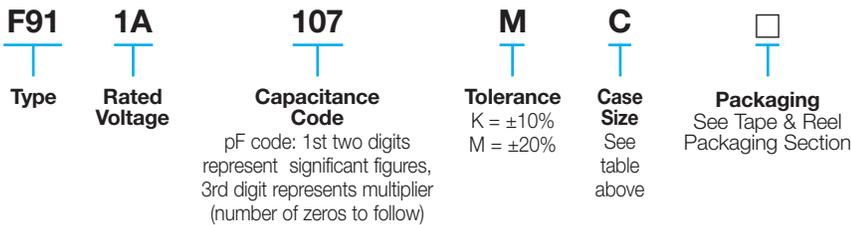
### CASE DIMENSIONS: millimeters (inches)

Code	L	W <sub>1</sub>	W <sub>2</sub>	H	S
B	3.50 ± 0.20 (0.126 ± 0.008)	2.80 ± 0.20 (0.110 ± 0.008)	2.20 ± 0.10 (0.087 ± 0.004)	1.90 ± 0.20 (0.075 ± 0.008)	0.80 ± 0.20 (0.031 ± 0.008)
C	6.00 ± 0.20 (0.236 ± 0.008)	3.20 ± 0.20 (0.126 ± 0.008)	2.20 ± 0.10 (0.087 ± 0.004)	2.50 ± 0.20 (0.098 ± 0.008)	1.30 ± 0.20 (0.051 ± 0.008)
N	7.30 ± 0.20 (0.287 ± 0.008)	4.30 ± 0.20 (0.169 ± 0.008)	2.40 ± 0.10 (0.094 ± 0.004)	2.80 ± 0.20 (0.110 ± 0.008)	1.30 ± 0.20 (0.051 ± 0.008)

### MARKING



### HOW TO ORDER



### TECHNICAL SPECIFICATIONS

Category Temperature Range:	-55 to +125°C
Rated Temperature:	+85°C
Capacitance Tolerance:	±20%, ±10% at 120Hz
Dissipation Factor:	Refer to next page
ESR 100kHz:	Refer to next page
Leakage Current:	After 1 minute's application of rated voltage, leakage current at 20°C is not more than 0.01CV or 0.5μA, whichever is greater. After 1 minute's application of rated voltage, leakage current at 85°C is not more than 0.1CV or 5μA, whichever is greater. After 1 minute's application of derated voltage, leakage current at 125°C is not more than 0.125CV or 6.3μA, whichever is greater.
Capacitance Change By Temperature	+15% Max. at +125°C +10% Max. at +85°C -10% Max. at -55°C

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### CAPACITANCE AND RATED VOLTAGE RANGE (LETTER DENOTES CASE SIZE)

Capacitance		Rated Voltage						
μF	Code	4V (0G)	6.3V (0J)	10V (1A)	16V (1C)	20V (1D)	25V (1E)	35V (1V)
6.8	685							C
10	106						C	N
15	156					C		N
22	226				B		N	N
33	336				B/C	N	N	
47	476			B	N	N	N	
68	686			C				
100	107		C	C	N			
150	157	C	C	N				
220	227	C	C/N	N				
330	337	N	N	N				
470	477	N	N					
680	687	N						

### RATINGS & PART NUMBER REFERENCE

AVX Part No.	Case Size	Capacitance (μF)	Rated Voltage (V)	DCL (μA)	DF (%) @ 120Hz	ESR (mΩ) @ 100kHz	100kHz RMS Current (mA)
							20°C
<b>4 Volt</b>							
F910G157MCC	C	150	4	6.0	12	250	663
F910G227MCC	C	220	4	8.8	12	250	663
F910G337MNC	N	330	4	13.2	10	100	1225
F910G477MNC	N	470	4	18.8	16	100	1225
F910G687MNC	N	680	4	27.2	18	100	1225
<b>6.3 Volt</b>							
F910J107MCC	C	100	6.3	6.3	8	250	663
F910J157MCC	C	150	6.3	9.5	12	250	663
F910J227MCC	C	220	6.3	13.9	14	250	663
F910J227MNC	N	220	6.3	13.9	10	100	1225
F910J337MNC	N	330	6.3	20.8	14	100	1225
F910J477MNC	N	470	6.3	29.6	16	100	1225
<b>10 Volt</b>							
F911A476MBA	B	47	10	4.7	8	500	412
F911A686MCC	C	68	10	6.8	8	300	606
F911A107MCC	C	100	10	10.0	10	250	663
F911A157MNC	N	150	10	15.0	10	100	1225
F911A227MNC	N	220	10	22.0	12	100	1225
F911A337MNC	N	330	10	33.0	18	100	1225
<b>16 Volt</b>							
F911C226MBA	B	22	16	3.5	8	950	299
F911C336MBA	B	33	16	5.3	8	950	299
F911C336MCC	C	33	16	5.3	6	400	524
F911C476MNC	N	47	16	7.6	6	150	1000
F911C107MNC	N	100	16	16	10	100	1225
<b>20 Volt</b>							
F911D156MCC	C	15	20	3	6	450	494
F911D336MNC	N	33	20	6.6	6	200	866
F911D476MNC	N	47	20	9.4	8	200	866
<b>25 Volt</b>							
F911E106MCC	C	10	25	2.5	6	450	494
F911E226MNC	N	22	25	5.5	6	200	866
F911E336MNC	N	33	25	8.3	8	200	866
F911E476MNC	N	47	25	11.8	8	250	775
<b>35 Volt</b>							
F911V685MCC	C	6.8	35	2.4	6	600	428
F911V106MNC	N	10	35	3.5	6	300	707
F911V156MNC	N	15	35	5.3	6	300	707
F911V226MNC	N	22	35	7.7	8	300	707

\* In case of capacitance tolerance ± 10% type, "K" will be put at 9th digit of type numbering system

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### QUALIFICATION TABLE

TEST	F91 series (Temperature range -55°C to +125°C)	
	Condition	
<b>Damp Heat (Steady State)</b>	At 40°C, 90 to 95% R.H., 500 hours (No voltage applied) Capacitance Change ..... Within ±10% of the initial value Dissipation Factor ..... Initial specified value or less Leakage Current ..... Initial specified value or less	
<b>Temperature Cycles</b>	-55°C / +125°C, 30 minutes each, 5 cycles Capacitance Change ..... Within ±5% of the initial value Dissipation Factor ..... Initial specified value or less Leakage Current ..... Initial specified value or less	
<b>Resistance to Soldering Heat</b>	10 seconds reflow at 260°C, 5 seconds immersion at 260°C. Capacitance Change ..... Within ±5% of the initial value Dissipation Factor ..... Initial specified value or less Leakage Current ..... Initial specified value or less	
<b>Surge</b>	After application of surge voltage in series with a 33Ω resistor at the rate of 30 seconds ON, 30 seconds OFF, for 1000 successive test cycles at 85°C, capacitors shall meet the characteristic requirements in the table above. Capacitance Change ..... Within ±5% of the initial value Dissipation Factor ..... Initial specified value or less Leakage Current ..... Initial specified value or less	
<b>Endurance</b>	After 2000 hours' application of rated voltage in series with a 3Ω resistor at 85°C, or derated voltage in series with a 3Ω resistor at 125°C, capacitors shall meet the characteristic requirements in the table above. Capacitance Change ..... Within ±10% of the initial value Dissipation Factor ..... Initial specified value or less Leakage Current ..... Initial specified value or less	
<b>Shear Test</b>	After applying the pressure load of 5N for 10±1 seconds horizontally to the center of capacitor side body which has no electrode and has been soldered beforehand on a substrate, there shall be found neither exfoliation nor its sign at the terminal electrode.	 5N (0.51kg · f) For 10±1 seconds
<b>Terminal Strength</b>	Keeping a capacitor surface-mounted on a substrate upside down and supporting the substrate at both of the opposite bottom points 45mm apart from the center of capacitor, the pressure strength is applied with a specified jig at the center of substrate so that the substrate may bend by 1mm as illustrated. Then, there shall be found no remarkable abnormality on the capacitor terminals.	